Erratum: Growth of $TlBa_2Ca_2Cu_3O_9$ Epitaxial Thin Films by Two-Step Method in Argon [Chin. Phys. Lett. 36 (2019) 057401]

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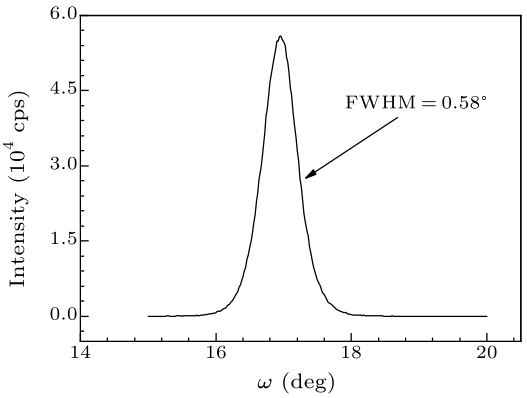

Fig. 2. Rocking curve of the (006) peak of the Tl-1223 thin film.

In Fig. 2 of the article,[1] the figure caption should be "Rocking curve of the (006) peak of the Tl-1223 thin film" instead of "Rocking curve of the (003) peak of the Tl-1223 thin film". The corresponding description of this figure should be "As shown in Fig. 2, the full width at half maximum (FWHM) of the Tl-1223(006) reflection peak is only 0.58°, which shows that the film possesses a good crystalline structure", instead of "As shown in Fig. 2, the FWHM of the Tl-1223(003) reflection peak is only 0.58°, which shows that the film possesses a good crystalline structure".

We note that this mistake does not affect the conclusion of our report, and apologize to readers for any inconvenience caused by our oversight.

References

[1] Xing J, Wang L T, Gao X X, Liang X X, He K K, Xue T, Zhao S H, Zhang J L, He M, Zhao X J, Yan S L, Wang P and Ji L 2019 *Chin. Phys. Lett.* **36** 057401

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